

<b>Notice of References Cited</b>	Application/Control No. 10/577,319		Applicant(s)/Patent Under Reexamination FRANZ ET AL.	
	Examiner JOSEPH T. PHAN		Art Unit 2614	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,975,828 A	12-1990	Wishneusky et al.	710/11
*	B	US-5,457,687 A	10-1995	Newman, Peter	370/232
*	C	US-5,706,279 A	01-1998	Teraslinna, Kari	370/232
*	D	US-5,793,843 A	08-1998	Morris, Walker C.	455/422.1
*	E	US-5,862,208	01-1999	MeLampy et al.	379/212.01
*	F	US-5,953,338 A	09-1999	Ma et al.	370/395.21
*	G	US-6,229,789 B1	05-2001	Simpson et al.	370/235
*	H	US-6,366,651 B1	04-2002	Griffith et al.	379/88.14
*	I	US-6,405,033 B1	06-2002	Kennedy et al.	455/414.1
*	J	US-6,426,944 B1	07-2002	Moore, Gregory D.	370/236
*	K	US-6,445,682 B1	09-2002	Weitz, Eliot	370/257
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1096770 A2	05-2001	European Patent	BAUER et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.